$\frac{\text{MOSFET}}{\text{DUAL COOL}^{\mathbb{R}} 33,}$ $\frac{\text{POWERTRENCH}^{\mathbb{R}}}{30 \text{ V}, 157 \text{ A}, 1.28 \text{ m}\Omega}$

General Description

This N–Channel MOSFET is produced using ON Semiconductor's advanced POWERTRENCH process. Advancements in both silicon and DUAL COOL package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance by extremely low Junction–to–Ambient thermal resistance.

Features

- DUAL COOL Top Side Cooling PQFN Package
- Max $r_{DS(on)} = 1.28 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 37 \text{ A}$
- Max $r_{DS(on)} = 1.74 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 32 \text{ A}$
- High Performance Technology for Extremely Low r_{DS(on)}
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Load Switch
- Motor Bridge Switch
- Synchronous Rectifier

MOSFET MAXIMUM RATINGS (T_A = 25°C Unless Otherwise Noted)

Symbol	Parameter	Ratings	Units
Vds	Drain to Source Voltage	30	V
Vgs	Gate to Source Volage (Note 4)	±20	V
ID	$\begin{array}{llllllllllllllllllllllllllllllllllll$	157 99 37 788	A
Eas	Single Pulse Avalance Energy (Note 3)	337	mJ
P _D	Power Dissipation $T_c = 25^{\circ}C$	50	W
	Power Dissipation $T_A = 25^{\circ}C$ (Note 1a)	3.0	
Тј, Тѕтс	Operating and Storage Junction Temperature Range	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
Rejc	Thermal Resistance, Junction to Case (Bottom Drain)	1.3	°C/W
Reja	Thermal Resistance, Junction to Ambient (Note 1a)	42	



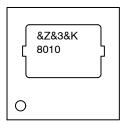
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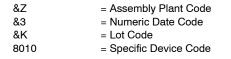
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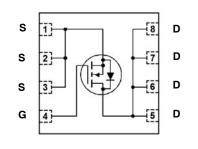


PQFN8 3.3X3.3, 0.65P CASE 483AY DUAL COOL 33

MARKING DIAGRAM







ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 2 of this data sheet.

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PACKAGE MARKING AND ORDERING INFORMATION

Q_{rr}

Reverse Recovery Charge

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8010	FDMC8010DC	DUAL COOL 33	13"	12 mm	3000 Units

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARAG	CTERISTICS	•		•	•	
BV _{DSS}	Drain to Source Breakdown Voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0 \ V$	30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$, referenced to $25^{\circ}C$		15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			10	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
ON CHARAC	TERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$	1.0	1.4	3.0	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25°C		-5		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 37 A		0.91	1.28	mΩ
		V _{GS} = 4.5 V, I _D = 32 A		1.2	1.74	
		V_{GS} = 10 V, I _D = 37 A, T _J = 125°C		1.34	1.89	1
9fs	Forward Transconductance	V _{DS} = 5 V, I _D = 37 A		231		S
OYNAMIC CH	IARACTERISTICS					-
C _{iss}	Input Capacitance	V_{DS} = 15 V, V_{GS} = 0 V,		4720	7080	pF
C _{oss}	Output Capacitance	f = 1 MHz		1540	2310	pF
C _{rss}	Reverse Transfer Capacitance			136	205	pF
Rg	Gate Resistance		0.1	0.5	1.1	Ω
	CHARACTERISTICS					-
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \text{ I}_{D} = 37 \text{ A}, \text{ V}_{GS} = 10 \text{ V},$		15	26	ns
t _r	Rise Time	-R _{GEN} = 6 Ω		7	14	ns
t _{d(off)}	Turn-Off Delay Time			40	64	ns
t _f	Fall Time			5	10	ns
Q _{g(TOT)}	Total Gate Charge at 10 V	V _{DD} = 15 V		67	94	nC
Q _{g(TOT)}	Total Gate Charge at 4.5 V	I _D = 37 A		32	44	nC
Qgs	Total Gate Charge	1		10		nC
Qgd	Gate to Drain "Miller" Charge	1		7.5		nC
RAIN-SOUP	RCE DIODE CHARACTERISTICS	•				
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.3 A (Note 2)		0.7	1.2	V
		V _{GS} = 0 V, I _S = 37 A (Note 2)		0.8	1.3	1
t _{rr}	Reverse Recovery Time	I _F = 37 A, di/dt = 100 A/μs		55	88	ns
		1		1 10		

48

76

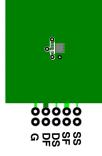
nC

THERMAL CHARACTERISTICS

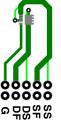
Rejc	Thermal Resistance, Junction to Case	(Top Source)	5.0	°C/W
Rejc	Thermal Resistance, Junction to Case	(Bottom Drain)	2.5	
Reja	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
Reja	Thermal Resistance, Junction to Ambient	(Note 1b)	105	
Reja	Thermal Resistance, Junction to Ambient	(Note 1c)	29	
Reja	Thermal Resistance, Junction to Ambient	(Note 1d)	40	
Reja	Thermal Resistance, Junction to Ambient	(Note 1e)	19	
Reja	Thermal Resistance, Junction to Ambient	(Note 1f)	23	
Reja	Thermal Resistance, Junction to Ambient	(Note 1g)	30	
Reja	Thermal Resistance, Junction to Ambient	(Note 1h)	79	
Reja	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
Reja	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
Reja	Thermal Resistance, Junction to Ambient	(Note 1k)	12	
Reja	Thermal Resistance, Junction to Ambient	(Note 1I)	16	

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 42°C/W when mounted on a 1 in² pad of 2 oz copper

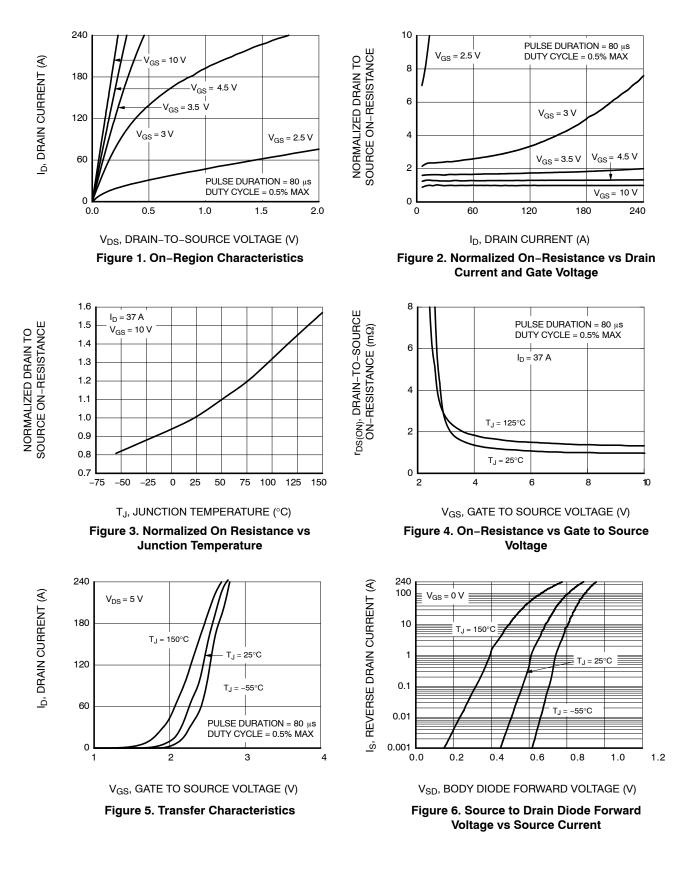


b. 105°C/W when mounted on a minimum pad of 2 oz copper

- c. Still air, 20.9x10.4x12.7 mm Aluminum Heat Sink, 1 in² pad of 2 oz copper.
- d. Still air, 20.9x10.4x12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper.
- e. Still air, 45.2x41.4x11.7 mm Aavid Thermalloy Part # 10–L41B–11 Heat Sink, 1 in² pad of 2 oz copper.
- f. Still air, 45.2x41.4x11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper.
- g. 200FPM Airflow, No Heat Sink,1 in² pad of 2 oz copper.
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper.
- i. 200FPM Airflow, 20.9x10.4x12.7 mm Aluminum Heat Sink, 1 in² pad of 2 oz copper.
- j. 200FPM Airflow, 20.9x10.4x12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper.
- k. 200FPM Airflow, 45.2x41.4x11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper.
- I. 200FPM Airflow, 45.2x41.4x11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper.
- 2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.
- 3. E_{AS} of 337 mJ is based on starting $T_J = 25^{\circ}C$, L = 3 mH, $I_{AS} = 15$ A, $V_{DD} = 30$ V, $V_{GS} = 10$ V, 100% test at L = 0.1 mH, $I_{AS} = 49$ A.
- 4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.
- 5. Pulse Id measured at 250 $\mu s,$ refer to Figure 11 SOA graph for more details.
- 6. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS

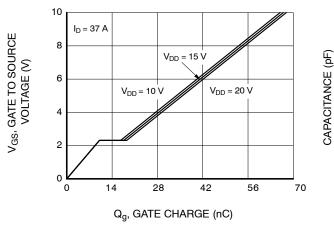
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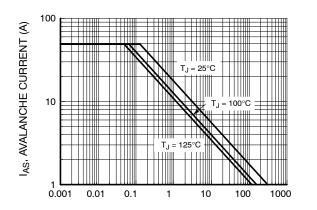
TYPICAL CHARACTERISTICS (continued)

 $T_J = 25^{\circ}C$ Unless Otherwise Noted

ID, DRAIN CURRENT (A)







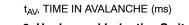
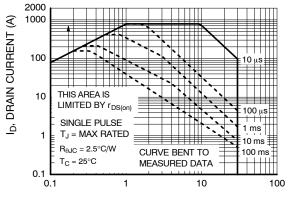
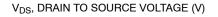
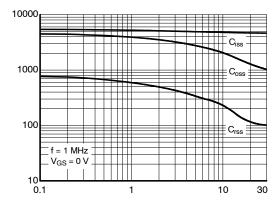


Figure 9. Unclamped Inductive Switching Capability



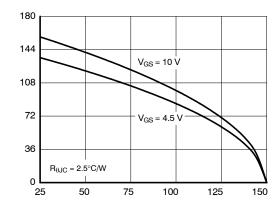






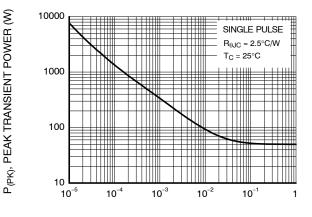
V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

Figure 8. Capacitance vs Drain to Source Voltage



T_C, CASE TEMPERATURE (°C)

Figure 10. Maximum Continuous Drain Current vs Case Temperature



t, PULSE WIDTH (sec)

Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

 T_J = 25°C Unless Otherwise Noted

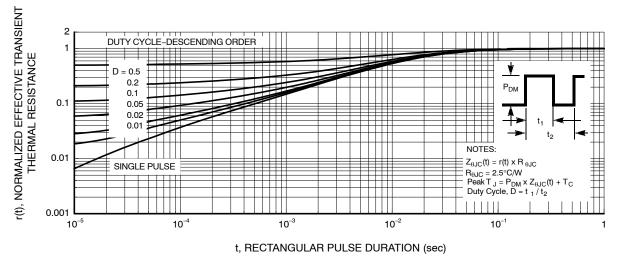
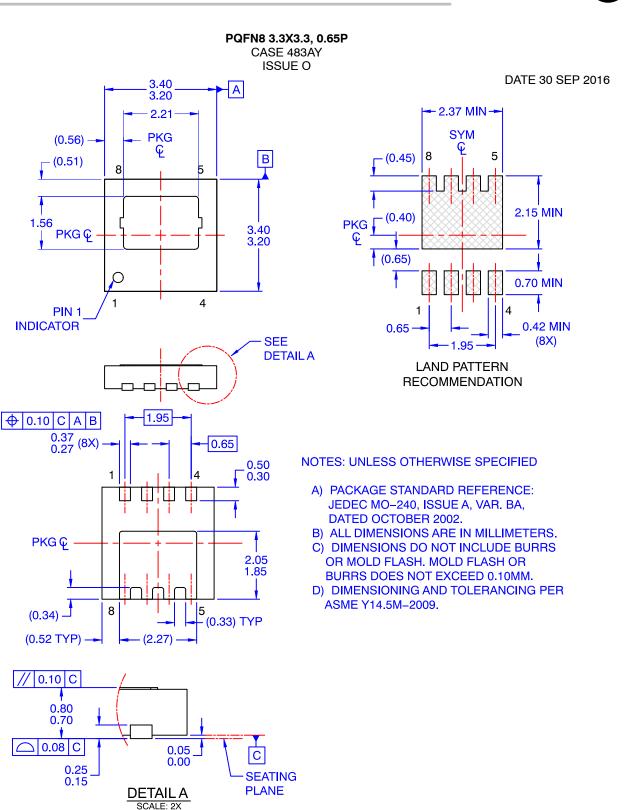


Figure 13. Junction to Case Transient Thermal Response Curve

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